

EMI TEST REPORT

According to FCC Part 15 Subpart B/Class B

Product : Wireless Hand PC
Model No. : S160

FCC ID : A3LS160

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3. This test report is to certify that the tested device properly complies with the requirements of FCC Rules and Regulations Part 15 Subpart B Unintentional Radiators.
All tests necessary to show compliance to the requirements were and these results met the specifications requirement.

Date of test : August 2, 2002 ~ August 5, 2002

Issued Date : August 14, 2002

Tested by:

Tae Young, JANG / Test Engineer

Reviewed by:

Yang Soo, KIM / Manager of EMC Lab.

Authorised by:

Kyu Baek, CHUNG / Chief of EMC Lab.

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NVLAP Code: 200447

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Distribution

This test report has been made available as follows:

CS Management Center, EMC Laboratory	1 original
Computer Division	1 copy

1. General Information

Applicant : Samsung Electronics Co., Ltd.

Full Address : 416 Maetan 3 Dong, Paldal-Ku,
Suwon City, Kyungki Do, Korea, 442-742

Kind of Product : **Wireless Hand PC**

FCC ID : **A3LS160**

Project Name : **Freesia**

Model & Variant Names : **S160** (Brand Name: Samsung)

Test Report Produced by : Tae Young, JANG / Test Engineer

7) Justification

The system was configured for testing in typical fashion use. Cable were attached to each of the available I/O Ports. Where applicable, peripherals were attached to the I/O cables. The mode of operation utilized for testing was selected to best simulate typical EUT use.

Further details of cabling and configuration are shown in the test system configuration.

8) Operating Frequency :

400MHz(CPU Speed), 3.6864MHz(Main Clock), 32.768KHz(RTC Clock),
100MHz(SDRAM Clock), 48MHz(LCD Controller Bus Clock),
27MHz(LCD Controller Pixel Clock), 27MHz(NAND Flash Controller Clock),
3.6864MHz(SA1111 Clock), 12.288MHz(Audio Bit Clock), 24.576MHz(Audio 97)

9) Description of Testing operating mode

Operating Mode	Operating section of EUT
"H" Pattern display	LCD Screen
	external Monitor(TFT-LCD)
Audio Output	audio to Ear-phone

10) Tested Resolution :

Tested Video mode	Resolutions	Refresh rates	Colors
LCD(5.0")	800 X 480	60Hz	16bits
Ext. Monitor	1280 X 1024	85Hz	32bits

11) Assemble Parts

Item	Specification	Remark
CPU	Intel PXA250 Xscale core 400MHz 32K / 32K / 2KB Cache	
Memory	Samsung, K9F1208U0M, NAND Falsh 64MB Samsung, K4S511533C-YN1L, SDRAM 128MB	
Graphic Contoller	Epson, S1D13806B00B100 48MHz LCD Controller Clock, 27MHz LCD Pixel Clock 64K Color(256 Color for dual display) Depth	
Flat Panel Dispay	SEC, LCD 5" TFT Upto 800x480 Pixels; 16-bit 64k colors White LED Backlight	
Companion Chip	Xilinx, XCR3032XL-10CS48C, CPLD Intel, SA1111	
Analog LSI	Wolfson, WM9705 TSP Controller, 18-bit stereo audio codecs Headphone drivers on AUX and MONO outputs Auxiliary ADC input for direct battery measurement	
AC Adapter	SEM, AD-1005, 100-120V, 0.6A, 50/60Hz, 2 pin	
Wireless LAN	SEM, SWL-2220C, Built-in Wi-Fi certified 802.11b	
Input Devices	Samsung, SKB-160E, Keyboard, CF Type II Samsung, SPA-160E, PCMCIA Adapter,	Optional Optional
Battery	Built-in, Lithium Polymer Rechargeable Battery	
Docking Cradle	Samsung, SDO-160E	DC-IN, SYNC cable or VGA cable IN
Ports	Extened Lithium Pollymer Rechargeable battery DC IN, HEADPHONE-OUT, CF Type II Slot, PCMCIA External Slot, VGA-OUT (SYNC-OUT)	Optional

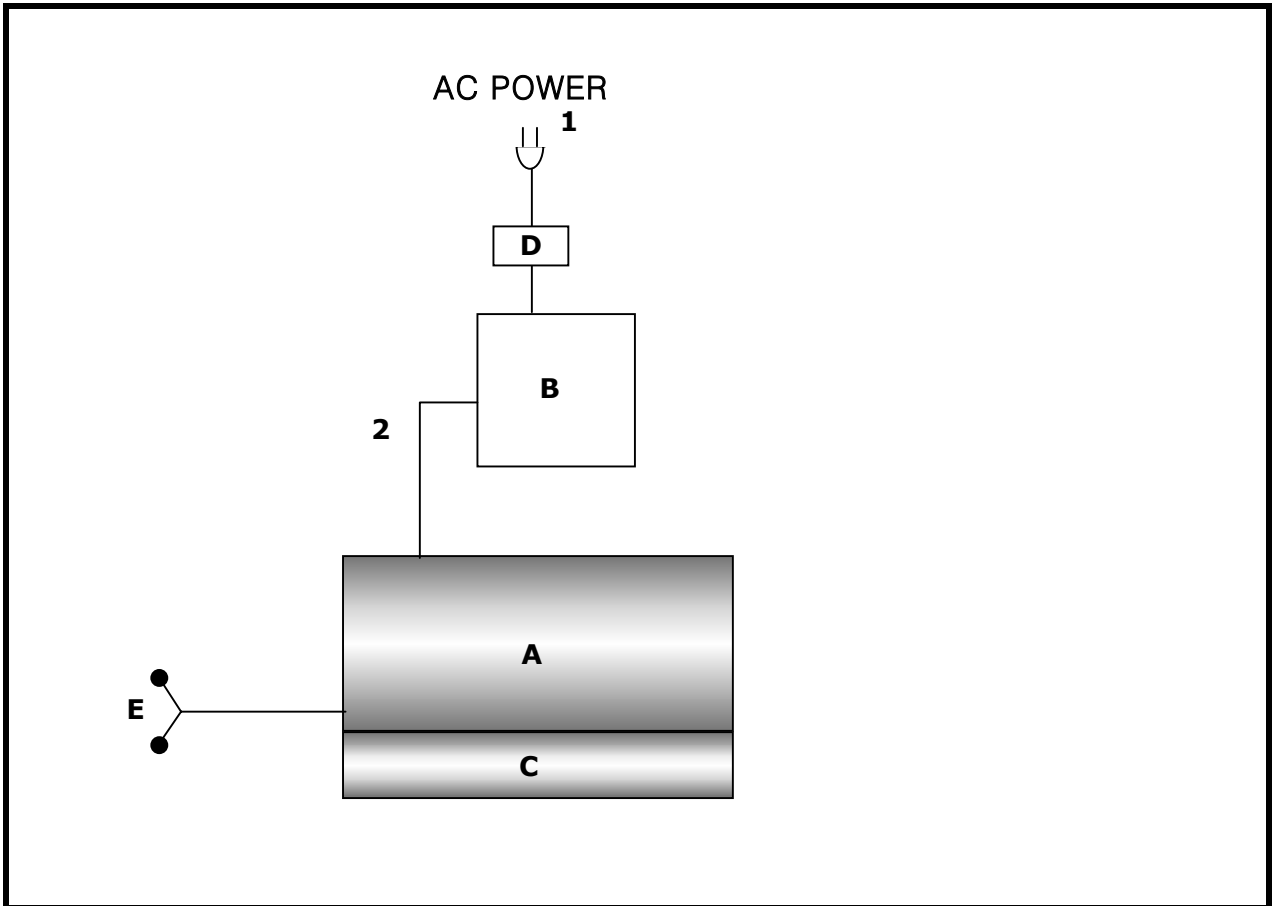
1.2 Configuration of EUT and peripherals

Mark	Item	Model No.	Serial No.	Manufacturer	FCC ID
A	Hand PC	S160	-	Samsung	A3LS160
B	Monitor	M17D-AN	N106H4JT100839	Samsung	Doc
C	Docking Cradle	SDO-160E	-	Samsung	-
D	Adapter	AD-4214N	C011108523	Samsung	-
E	Earphone Cable	-	-	-	-
F					
G					
H					
I					
J					
K					
L					
M					
N					
O					

1.3 Used Cable Description

No.	Item	Length[m]	Shielded (Y/N)	Remark
1	AC Power Cable	1.5	N	
2	Earphone Cable	1.0	N	
3	Monitor Cable	1.6	Y	
4				
5				
6				
7				
8				
9				
10				
11				
12				

1.4 System Block Diagram of Test Configuration



1.5 Test Facility

All test described in this report were performed by :
SAMSUNG ELECTRONICS CO., LTD.
EMC TESTING LABORATORY
416 Maetan 3 Dong, Paldal-Ku, Suwon City, Kyungki Do, Korea, 442-742
Semi Anechoic Chamber #2(Registration Number:873282) and Shielded Room.

This test facility has been filed in FCC under the criteria in ANSI C63.4-1992.

2. System Test Configuration

2.1 Configuration of Radiated and Conducted Interference Measurement

* Cabling was taken into consideration and test data was taken under worse case conditions.

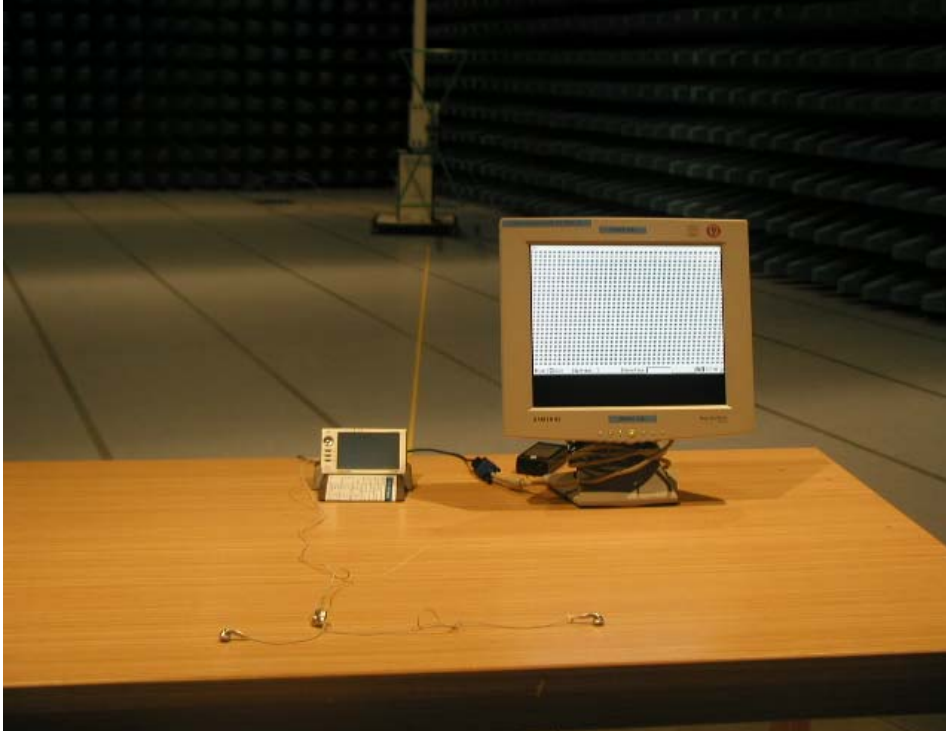
1)Conduction(Front View)



2)Conduction(Rear View)



3) Radiation(Front View)



4) Radiation(Rear View)



2.2 Operation Environment

	Conduction	Radiation
Temperature [C] :	21.5C	25.5C
Humidity [%]	65	54
Power supply	: AC220V/60Hz	AC220V/60Hz

2.3 Test Procedure

2.3.1 Conducted Emissions

EUT was placed on a platform of nominal size, 1m by 1.5m, raised 80cm above the conducting ground plane. The rear of tabletop was located 40cm to the vertical conducting ground plane.

The rear of EUT, including peripherals was aligned and flush with rear of tabletop. All other surfaces of tabletop was at least 80cm from any other grounded conducting surface. I/O cables and AC cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30cm to 40cm long and were hanged at a 40cm height to the ground plane.

Each EUT current-carrying power lead, except the ground(safety) lead, were individually connected through a LISN to the input power source.

All unused 50 ohm connectors of the LISN were resistively terminated in 50 ohm when not connected to the measuring equipment.

The EUT was switched on and allowed to warm up to its normal operating condition.

A quick scan, from 150kHz to 30MHz, was made on the L1 & L2 line by LISN.

High peaks, relative to the limit line, over the frequency range were then selected.

The EMI TEST RECEIVER was then tuned to the selected frequencies.

CISPR quasi-peak measurements with a receiver bandwidth setting of 10kHz, were taken.

2.3.2 Radiated Emissions

EUT was placed on a platform of nominal size, 1m by 1.5m, raised 80cm above the conducting ground plane.

The rear of EUT, including peripherals was aligned and flush with rear of tabletop. I/O cables that were connected to the peripherals were bundle in center.

They were folded back and forth forming a bundle 30cm to 40cm long and were hanged 40cm height to the ground plane.

The system configuration, clock speed, mode of operation or video resolution, turntable azimuth with respect to the antenna were noted for each frequency found. The spectrum was scanned from 30 to 1000 MHz using biconiLog antenna. Also, the EMI TEST RECEIVER was scanned from 1000 to 18000MHz using linearly polarized double ridge horn antennas were used.

Each emission was maximized by: varying the mode of operation or resolution; clock or data exchange speed; scrolling H pattern to the EUT and/or support equipment; powering the monitor from the floor mounted outlet box and the computer aux AC outlet if applicable, and changing the polarity of the antenna; whichever determined the worst-case emission.

The explanation of measuring instrument setup when respective function is used in any frequency band is as following:

Frequency Band [MHz]	Instrument	Detector function	resolution Bandwidth	Video Bandwidth
30 to 1000	Spectrum analyzer	Peak	1MHz	1MHz
	EMI Test receiver	Quasi-Peak	120kHz	-
Above 1000	EMI Test receiver	Peak	1MHz	-

3. Conducted Emission Test Data

O Test Data Sheet

Frequency [MHz]	Meter reading (a)		Total Loss (b) [dB]	Results (a) + (b)		Limits		Margin (Limits-Result)	
	QP	AV		QP	AV	QP	AV	QP	AV
	[dBuV]			[dBuV]		[dBuV]		[dB]	
0.162	50.4	-	0.6	51.0	-	65.4	55.4	14.4	4.4
0.181	48.9	-	0.6	49.5	-	64.4	54.4	14.9	4.9
0.189	50.3	-	0.6	50.9	-	64.1	54.1	13.2	3.2
0.240	40.8	-	0.6	41.4	-	62.1	52.1	20.7	10.7
0.295	41.0	-	0.5	41.5	-	60.4	50.4	18.9	8.9
0.494	36.1	-	0.6	36.7	-	56.1	46.1	19.4	9.4
0.677	39.0	-	0.6	39.6	-	56.0	46.0	16.4	6.4
0.720	35.2	-	0.5	35.7	-	56.0	46.0	20.3	10.3
1.568	35.8	-	0.6	36.4	-	56.0	46.0	19.7	9.7
1.662	36.2	-	0.5	36.7	-	56.0	46.0	19.3	9.3
2.642	34.5	-	0.6	35.1	-	56.0	46.0	20.9	10.9
3.451	34.2	-	0.7	35.0	-	56.0	46.0	21.0	11.0
5.345	35.6	-	0.8	36.4	-	60.0	50.0	23.6	13.6
6.978	34.2	-	0.8	35.0	-	60.0	50.0	25.0	15.0
7.095	34.5	-	0.8	35.3	-	60.0	50.0	24.7	14.7
8.084	30.1	-	1.0	31.1	-	60.0	50.0	28.9	18.9
21.291	37.7	-	1.7	39.4	-	60.0	50.0	20.6	10.6
26.634	36.7	-	2.1	38.8	-	60.0	50.0	21.2	11.2

* QP : Quasi-peak, AV: Average

* Results = Meter Reading(QP or AV) + Total Loss(LISN Insertion loss + Cable loss)

**"-":The Quasi-peak reading value also meets average limit so it is not necessary to measure with Average detector

* Measurement detector function and bandwidth

Detector function : CISPR quasi-peak

Bandwidth : 10kHz

4. Radiated Emission Test Data

Frequency Range [MHz]	Tested Frequency [MHz]	ANT Pol.	Meter Reading [A] [dBuV/m]	Total Loss [B] [dB]	Antenna Height [Cm]	Turn table Degree [Deg]	Results [A+B] [dBuV/m]	Limits [dBuV/m]	Margin (Limit-Result) [dB]
30 - 230	32.0	V	4.1	17.8	107	42	21.9	30.0	8.1
	53.3	V	9.0	7.9	100	198	16.9	30.0	13.1
	69.2	V	10.5	6.7	279	176	17.2	30.0	12.8
	74.6	V	10.8	7.2	236	0	18.0	30.0	12.0
	100.8	V	2.5	12.1	193	176	14.6	30.0	15.4
	106.2	V	1.1	12.8	100	148	13.9	30.0	16.1
	159.7	H	5.0	11.7	400	97	16.7	30.0	13.3
	184.3	V	8.6	10.4	102	347	19.0	30.0	11.0
	208.9	V	10.4	10.8	100	238	21.2	30.0	8.8
213.0	H	9.3	10.4	400	259	19.7	30.0	10.3	
230 - 1000	454.6		8.9	20.1	250	75	29.0	37.0	8.0
	741.8	V	6.0	24.4	178	35	30.4	37.0	6.6
	985.3	H	0.6	25.8	178	148	26.4	37.0	10.6
1000 - 2000	1035.0	V	13.2	28.6	100	0	41.8	74.0	32.2
	1901.0	V	9.9	33.2	100	0	43.1	74.0	30.9

* "<" Means equal or less then 5dB

* Receiving Antenna Mode : **Horizontal, Vertical**

* Results = Meter Reading + Total Loss(Antenna factor + Cable loss)

* Measurement detector function and bandwidth

Detector function : CISPR quasi-peak(Above 1000MHz: Peak)

Resolution Bandwidth : 120kHz(Above 1000MHz: 1MHz)

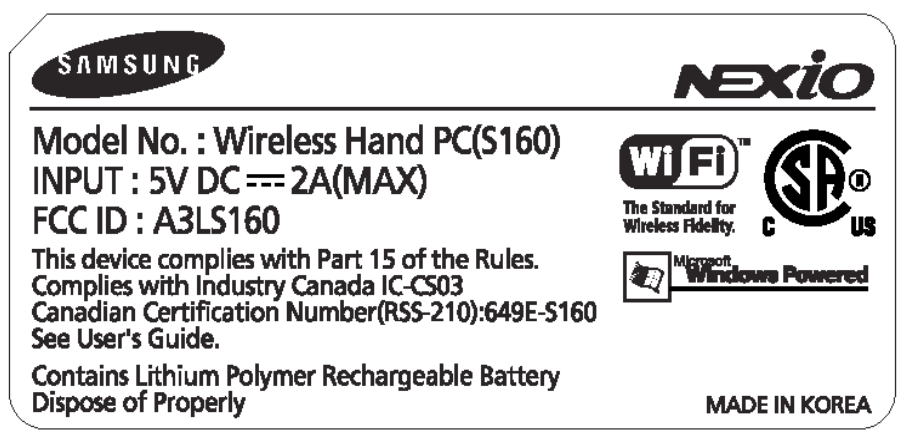
* Test distance

- Below 1000MHz: 10m(Quasi-peak)

- Above 1000MHz: 3m(Peak)

5. FCC Label Configuration and Location

5.1 Label Configuration



5.2 Location of Label



6. Test Equipment Used

Equipment	Model No.	Makers.	Serial No	Calibration Last calibration and Interval
Field strength meter	ESCS30	830986/004	R & S	2003-02-15
	Firmware versions : Main 2.22, OTP 02.01, GRA 02.36			
Test Receiver	ESI26	100010	R&S	2003-05-04
L.I.S.N	ESH2-Z5	831886/006	R & S	2002-11-20
L.I.S.N	ESH3-Z5	831887/0004	R & S	2003-08-06
Horn Antenna	HF906	100028	R & S	2003-07-26
BILOG Antenna	CBL6112B	2804	Schaffner	2003-04-23